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Applicant: Jongill et al.

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U.S. PATENT DOCUMENTS

Examiner Initial*	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate

FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
W4	10041561	Feb. 13, 1998	Japan			Abs.	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

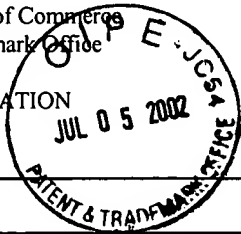
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Form PTO-1449 (Rev. 8-88)	U.S. Department of Commerce Patent and Trademark Office	Attorney Docket No.: 1115.64887	Serial No.: 09/726,752
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U.S. PATENT DOCUMENTS

Examiner Initial*	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate

FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
754	490 608	Jun. 17, 1992	Europe			X	

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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

754	J.J. deVries et al.; "Oscillatory Interlayer Exchange Coupling with the Cu Cap Layer Thickness in Co/Cu/Co/Cu(100)"; <i>Physical Review Letters</i> ; Vol. 75, No. 23; pp. 4306-4309; Dec. 4, 1995.
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754	K. Matsuyama et al.; "Perpendicular spin valve behavior in a microstructrued Co/Cu-Cu oxide/Co trilayer"; <i>Journal of Applied Physics</i> ; Vol. 79, No. 8, Part 2A, pp. 5318-5320; April 15, 1996.

Examiner		Date Considered	3/25/03
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